

Notice of References Cited	Application/Control No. 10/684,469		Applicant(s)/Patent Under Reexamination SAITO, HITOSHI	
	Examiner Craig A. Renner		Art Unit 2652	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,724,497	02-1988	Takeda et al.	360/99.06
*	B	US-5,513,054 A	04-1996	Watanabe, Takashi	360/99.06
*	C	US-5,537,673 A	07-1996	Nagashima et al.	455/346
*	D	US-5,633,768 A	05-1997	Watanabe, Takashi	360/99.01
*	E	US-5,648,882 A	07-1997	Tangi et al.	360/99.06
*	F	US-5,979,836 A	11-1999	Kim, Sung-Seop	248/27.3
*	G	US-6,904,606 B2	06-2005	Inoue et al.	720/646
*	H	US-2002/0114106 A1	08-2002	Kohyama et al.	360/99.06
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 04245059 A	09-1992	Japan	HOSHI, AKIO	G11B 17/04
	O	JP 07029279 A	01-1995	Japan	SUZUKI, YUJI	G11B 17/04
	P	JP 07073661 A	03-1995	Japan	MIDORIKAWA, KOJI	G11B 33/02
	Q	JP 08255396 A	10-1996	Japan	SUGANUMA et al.	G11B 17/04
	R	JP 2002160585 A	06-2002	Japan	KOMORI, TAKANAO	G11B 33/02
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.